







SN54AHC08, SN74AHC08

SCLS236L - OCTOBER 1995 - REVISED FEBRUARY 2024

SNx4AHC08 Quadruple 2-Input Positive-AND Gates

1 Features

- 2V to 5.5V operating range
- Latch-up performance exceeds 250mA per JESD
- ESD protection exceeds JESD 22

2 Applications

- Servers
- **Network Switches**
- PCs and Notebooks
- Electronic Points of Sale

3 Description

The SNx4AHC08 devices are quadruple 2-input positive-AND gates. These devices perform the Boolean function $Y = A \cdot B$ or $Y = \overline{A + B}$ in positive logic.

Device Information

PART NUMBER	PACKAGE ⁽¹⁾	BODY SIZE(2)
	D (SOIC, 14)	8.65mm × 3.90mm
	DB (SSOP, 14)	6.20mm × 5.30mm
	DGV (TVSOP, 14)	3.60mm × 4.40mm
SN74AHC08	N (PDIP, 14)	19.30mm × 6.35mm
3N74A11000	NS (SO, 14)	10.30mm × 5.30mm
	PW (TSSOP, 14)	5.00mm × 4.40mm
	RGY (VQFN, 14)	3.50mm × 3.50mm
	BQA (WQFN, 14)	3mm × 2.5mm
SN54AHC08	FK (LCCC, 20)	8.89mm × 8.89mm

- For more information, see Section 11.
- The body size (length × width) is a nominal value and does not include pins.



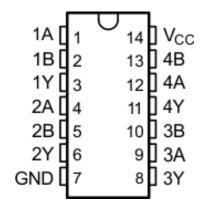


Table of Contents

1 Features1	7.1 Overview1	2
2 Applications	7.2 Functional Block Diagram1	
3 Description1	7.3 Feature Description1	
4 Pin Configuration and Functions3	7.4 Device Functional Modes1	
5 Specifications5	8 Application and Implementation1	3
5.1 Absolute Maximum Ratings5	8.1 Application Information1	3
5.2 ESD Ratings5	8.2 Typical Application1	3
5.3 Recommended Operating Conditions5	8.3 Layout1	5
5.4 Thermal Information6	9 Device and Documentation Support1	6
5.5 Electrical Characteristics, T _A = 25°C6	9.1 Documentation Support1	6
5.6 Electrical Characteristics, T _A = –55°C to 125°C7	9.2 Receiving Notification of Documentation Updates1	6
5.7 Electrical Characteristics, T _A = -40°C to 125°C7	9.3 Support Resources1	
5.8 Switching Characteristics, V _{CC} = 3.3 V ± 0.3 V8	9.4 Trademarks1	6
5.9 Switching Characteristics, V _{CC} = 5 V ± 0.5 V8	9.5 Electrostatic Discharge Caution1	6
5.10 Noise Characteristics9	9.6 Glossary1	6
5.11 Operating Characteristics9	10 Revision History1	6
5.12 Typical Characteristics10	11 Mechanical, Packaging, and Orderable	
6 Parameter Measurement Information11	Information1	7
7 Detailed Description12		



4 Pin Configuration and Functions



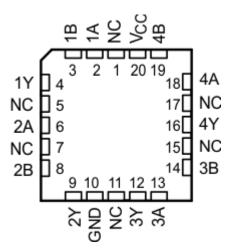


Figure 4-1. D, DB, DGV, N, NS, PW, or W Package 14-Pin SOIC, SSOP, TVSOP, PDIP, SO, or TSSOP (Top View)

Figure 4-2. FK Package 20-Pin LCCC (Top View)

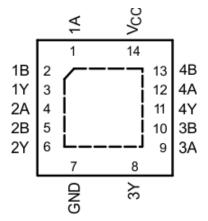


Figure 4-3. RGY or BQA Package 14-Pin VQFN or WQFN (Top View)



Table 4-1. Pin Functions

		PIN			
NAME	SOIC, SSOP, TVSOP, PDIP, SO, TSSOP	VQFN, WQFN	LCCC	I/O	DESCRIPTION
1A	1	1	2	I	1A Input
1B	2	2	3	I	1B Input
1Y	3	3	4	0	1Y Output
2A	4	4	6	1	2A Input
2B	5	5	8	1	2B Input
2Y	6	6	9	0	2Y Output
3Y	8	8	12	0	3Y Output
3A	9	9	13	1	3A Input
3B	10	10	14	1	3B Input
4Y	11	11	16	0	4Y Output
4A	12	12	18	1	4A Input
4B	13	13	19	I	4B Input
GND	7	7	10	_	Ground Pin
NC	_	_	1, 5, 7, 11, 15, 17	_	No Connection
V _{CC}	14	14	20	_	Power Pin



5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

			MIN	MAX	UNIT
V _{CC}	Supply voltage		-0.5	7	V
VI	Input voltage ⁽²⁾	-0.5	7	V	
Vo	Output voltage, V _O ⁽²⁾	-0.5	V _{CC} + 0.5	V	
I _{IK}	Input clamp current	V _I < 0		-20	mA
I _{OK}	Output clamp current	$V_O < 0$ or $V_O > V_{CC}$		±20	mA
Io	Continuous output current	$V_O = 0$ to V_{CC}		±25	mA
	Continuous current through V _{CC} or GND		±50	mA	
TJ	Junction temperature		150	°C	
T _{stg}	Storage temperature		-65	150	°C

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

5.2 ESD Ratings

			VALUE	UNIT
V	Lectrostatic	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000	V
V _{(ESD}	⁾ discharge	Charged device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±1000	V

⁽¹⁾ JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process. Manufacturing with less than 500-V HBM is possible with the necessary precautions.

5.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)(1)

			MIN	MAX	UNIT	
V _{CC}	Supply voltage		2	5.5	V	
		V _{CC} = 2 V	1.5			
V _{IH}	High-level input voltage	V _{CC} = 3V	2.1		V	
		V _{CC} = 5.5 V	3.85			
		V _{CC} = 2 V		0.5		
V _{IL}	Low-level Input voltage	V _{CC} = 3 V		0.9	V	
		V _{CC} = 5.5 V		1.65		
Vı	Input voltage		0	5.5	V	
Vo	Output voltage		0	V _{CC}	V	
		V _{CC} = 2 V		-50		
I _{OH}	High-level output current	V _{CC} = 3.3 V ± 0.3 V		-4	mA	
		V _{CC} = 5 V ± 0.5 V		-8		
		V _{CC} = 2 V		50		
I _{OL}	Low-level output current	V _{CC} = 3.3 V ± 0.3 V		4	mA	
		V _{CC} = 5 V ± 0.5 V		8		
Δt/Δν	Input Transition rice or fell rate	V _{CC} = 3.3 V ± 0.3 V		100	no/\/	
ΔυΔν	Input Transition rise or fall rate	V _{CC} = 5 V ± 0.5 V		20	ns/V	

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⁽²⁾ The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

⁽²⁾ JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process. Manufacturing with less than 250-V CDM is possible with the necessary precautions.



over operating free-air temperature range (unless otherwise noted)(1)

			MIN	MAX	UNIT
T _A	Operating free air temperature	SN54AHC08	-55	125	°C
	Operating free-air temperature SN74AHC08		-40	125	C

All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, SCBA004.

5.4 Thermal Information

					SN7	4AHC08				
	THERMAL METRIC ⁽¹⁾	D (SOIC)	DB (SSOP)	DGV (TVSOP)	N (PDIP)	NS (SO)	PW (TSSOP)	RGY (VQFN)	BQA (WQFN)	UNIT
		14 PINS	14 PINS	14 PINS	14 PINS	14 PINS	14 PINS	14 PINS	14 PINS	
R _{θJA}	Junction-to-ambient thermal resistance	124.5	96	127	80	76	147.7	87.1	88.3	°C/W

⁽¹⁾ For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

5.5 Electrical Characteristics, $T_A = 25$ °C

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{CC}	MIN	TYP	MAX	UNIT
		2 V	1.9	2		
	I _{OH} = -50 μA	3 V	2.9	3		
V_{OH}		4.5 V	4.4	4.5		V
	I _{OH} = -4 mA	3 V	2.58			
	I _{OH} = -8 mA	4.5 V	3.94			
		2 V			0.1	
	I _{OL} = 50 μA	3 V			0.1	
V_{OL}		4.5 V			0.1	V
	I _{OH} = 4 mA	3 V			0.36	
	I _{OH} = 8 mA	4.5 V			0.36	
I _I	V _I = 5.5 V or GND	0 V to 5.5 V			±0.1	μA
Icc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			2	μA
Ci	V _I = V _{CC} or GND	5 V		4	10	pF

Product Folder Links: SN54AHC08 SN74AHC08



5.6 Electrical Characteristics, $T_A = -55$ °C to 125°C

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V	SN54AHC08	UNIT
PARAMETER	TEST CONDITIONS	V _{cc}	MIN MAX	UNII
		2 V	1.9	
	$I_{OH} = -50 \mu A$	3 V	2.9	
V _{OH}		4.5 V	4.4	V
	I _{OH} = -4 mA	3 V	2.48	
	I _{OH} = -8 mA	4.5 V	3.8	
		2 V	0.1	
	I _{OL} = 50 μA	3 V	0.1	
V _{OL}		4.5 V	0.1	V
	I _{OH} = 4 mA	3 V	0.5	
	I _{OH} = 8 mA	4.5 V	0.5	
l _i	V _I = 5.5 V or GND	0 V to 5.5 V	±1 ⁽¹⁾	μA
Icc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V	20	μA
Ci	V _I = V _{CC} or GND	5 V		pF

⁽¹⁾ On products compliant to MIL-PRF-38535, this parameter is not production tested at VCC = 0 V.

5.7 Electrical Characteristics, $T_A = -40$ °C to 125°C

over operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST CONDITIONS	,	_	SN74AHC08	LIMIT
PARAMETER	TEST CONDITIONS	V _{cc}	T _A	MIN MAX	UNIT
		2 V		1.9	
	I _{OH} = -50 μA	3 V		2.9	
V _{OH}		4.5 V		4.4	V
	I _{OH} = -4 mA	3 V		2.48	
	I _{OH} = -8 mA	4.5 V		3.8	
	I _{OL} = 50 μA	2 V		0.	
		3 V		0.	
		4.5 V		0.	1
	I _{OH} = 4 mA		T _A = -40°C to 85°C	0.44	
V _{OL}		3 V	T _A = -40°C to125°C Recommended	0.9	5 V
			T _A = -40°C to 85°C	0.44	Ī
	I _{OH} = 8 mA	4.5 V	T _A = -40°C to125°C Recommended	0.9	5
I _I	V _I = 5.5 V or GND	0 V to 5.5 V		±.	μA
Icc	V _I = V _{CC} or GND, I _O = 0	5.5 V		20	μΑ
Ci	V _I = V _{CC} or GND	5 V	$T_A = -40^{\circ}\text{C to } 85^{\circ}\text{C}$	10	pF



5.8 Switching Characteristics, V_{CC} = 3.3 V \pm 0.3 V

over recommended operating free-air temperature range (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	T _A	MIN	TYP	MAX	UNIT	
				T _A = 25°C		6.2 ⁽¹⁾	8.8 ⁽¹⁾		
t _{PLH} , t _{PHL} A or B				T _A = -55°C to 125°C, SN54AHC08		1 ⁽¹⁾	10.5 ⁽¹⁾		
	A or B	A or B Y	Y C _L = 15 pF	C _L = 15 pF	$T_A = -40$ °C to 85°C, SN74AHC08		1	10.5	ns
				T _A = -40°C to 125°C Recommended, SN74AHC08		1	10.5		
				T _A = 25°C		8.7	12.3		
				T _A = -55°C to 125°C, SN54AHC08		1	14		
t _{PLH} , t _{PHL}	A or B	Y	C _L = 50 pF	$T_A = -40^{\circ}\text{C to } 85^{\circ}\text{C, SN74AHC08}$ 1	1	14	ns		
				T _A = -40°C to 125°C Recommended, SN74AHC08		1	14		

⁽¹⁾ On products compliant to MIL-PRF-38535, this parameter is not production tested.

5.9 Switching Characteristics, V_{CC} = 5 V ± 0.5 V

over recommended operating free-air temperature range (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	T _A	MIN	TYP	MAX	UNIT
t _{PLH} , t _{PHL} A or B Y				T _A = 25°C		4.3 ⁽¹⁾	5.9 ⁽¹⁾	
			T _A = -55°C to 125°C, SN54AHC08		1 ⁽¹⁾	7 ⁽¹⁾		
	Y	C _L = 15 pF	T _A = -40°C to 85°C, SN74AHC08		1	7	ns	
				T _A = -40°C to 125°C Recommended, SN74AHC08		1	7	
			C _L = 50 pF	T _A = 25°C		5.8	7.9	
				T _A = -55°C to 125°C, SN54AHC08		1	9	
t _{PLH} , t _{PHL}	A or B	Y		T _A = -40°C to 85°C, SN74AHC08		1	9	ns
				T _A = -40°C to 125°C Recommended, SN74AHC08		1	9	

⁽¹⁾ On products compliant to MIL-PRF-38535, this parameter is not production tested.

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5.10 Noise Characteristics

 $V_{CC} = 5 \text{ V}, C_L = 50 \text{ pF}, T_A = 25^{\circ}\text{C}^{(1)}$

		SN74AH0	SN74AHC08	
		MIN	MAX	UNIT
V _{OL(P)}	Quiet output, maximum dynamic V _{OL}		0.8	V
V _{OL(V)}	Quiet output, minimum dynamic V _{OL}		-0.8	V
V _{OH(V)}	Quiet output, minimum dynamic V _{OH}	4.4		V
V _{IH(D)}	High-level dynamic input voltage	3.5		V
$V_{IL(D)}$	Low-level dynamic input voltage		1.5	V

⁽¹⁾ Characteristics are for surface-mount packages only.

5.11 Operating Characteristics

 V_{CC} = 5 V, T_A = 25°C

	PARAMETER	TEST CONDITIONS	TYP	UNIT
C _{pd}	Power dissipation capacitance	No load, f = 1 MHz	18	pF



5.12 Typical Characteristics

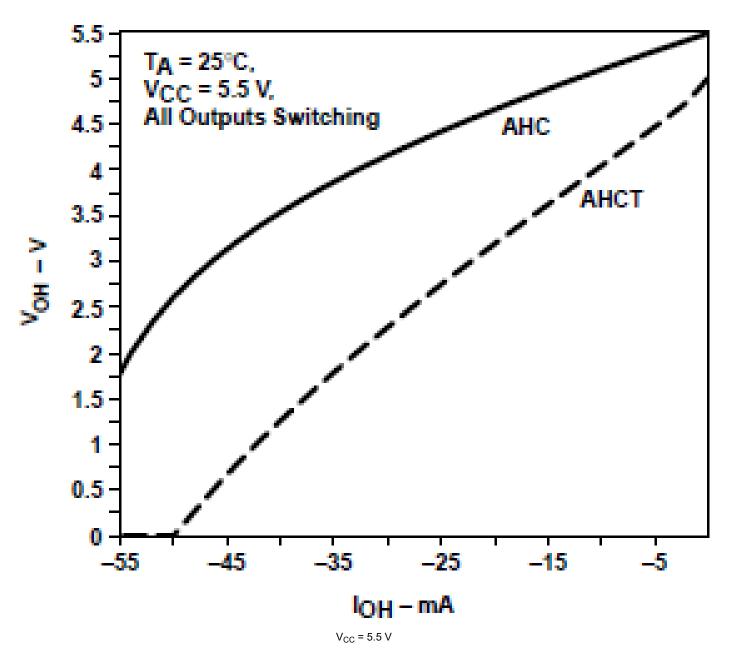
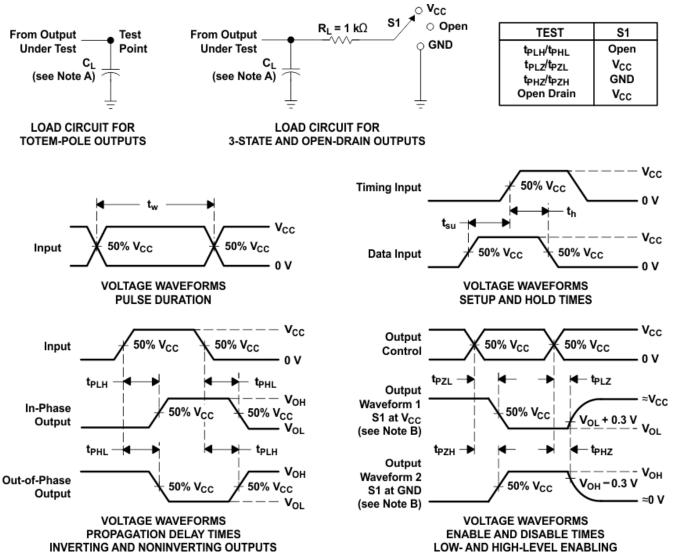


Figure 5-1. AHC Family V_{OL} vs I_{OL}



6 Parameter Measurement Information



- A. C_L includes probe and jig capacitance.
- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \Omega$, $t_r \leq$ 3 ns, $t_f \leq$ 3 ns.
- D. The outputs are measured one at a time with one input transition per measurement.
- E. All parameters and waveforms are not applicable to all devices.

Figure 6-1. Load Circuit and Voltage Waveforms

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7 Detailed Description

7.1 Overview

The SNx4AHC08 devices are quadruple 2-input positive-AND gates with low drive that will produce slow rise and fall times. This slow transition reduces ringing on the output signal. The inputs are high impedance when $V_{CC} = 0 \text{ V}$.

7.2 Functional Block Diagram



7.3 Feature Description

Slow rise and fall time on outputs allow for low-noise outputs.

7.4 Device Functional Modes

Table 7-1 is the function table for the SNx4AHC08.

Table 7-1. Function Table (Each Gate)

INF	PUTS	OUTPUT
Α	В	Y
Н	Н	Н
L	Х	L
X	L	L

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8 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

8.1 Application Information

A common application for AND gates is the use in power sequencing. Power sequencing is often employed in applications that require a processor or other delicate device with specific voltage timing requirements in order to protect the device from malfunctioning. Using the SN74AHC08 to verify that the processor has turned on can protect it from harmful signals.

8.2 Typical Application

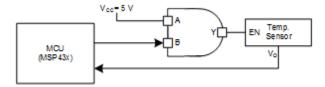


Figure 8-1. Typical Application Diagram

8.2.1 Design Requirements

This device uses CMOS technology and has balanced output drive. Take care to avoid bus contention because it can drive currents that would exceed maximum limits. The high drive will also create fast edges into light loads, so routing and load conditions must be considered to prevent ringing.

8.2.2 Detailed Design Procedure

- 1. Recommended input conditions
 - Rise time and fall time specs: See (Δt/Δv) in the Section 5.3 table.
 - Specified High and low levels: See (V_{IH} and V_{II}) in the Section 5.3 table.
 - Inputs are overvoltage tolerant allowing them to go as high as 5.5 V at any valid V_{CC}
- 2. Recommend output conditions
 - Load currents should not exceed 25 mA per output and 50 mA total for the part
 - Outputs should not be pulled above V_{CC}



8.2.3 Application Curve

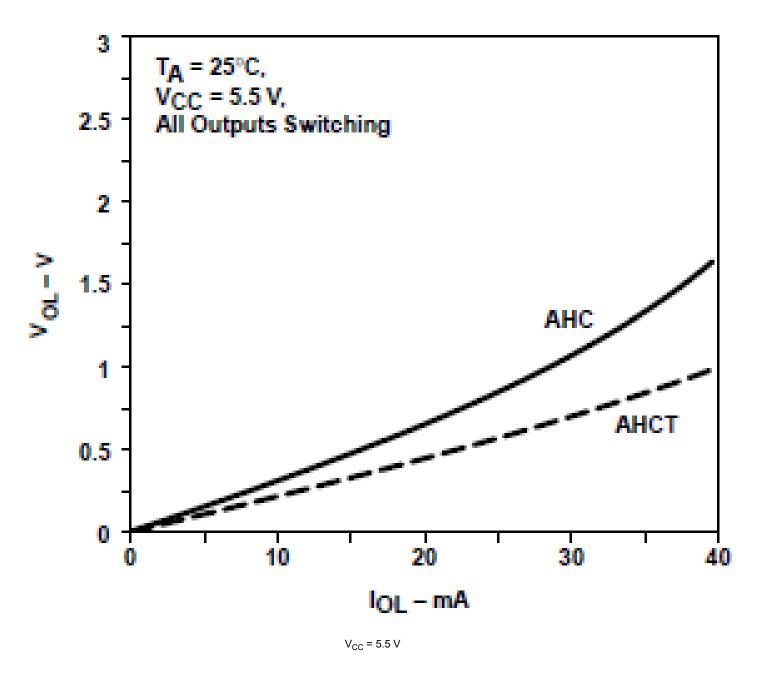


Figure 8-2. AHC Family V_{OH} vs I_{OH}

Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the Section 5.1 table.

Each V_{CC} pin should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, 0.1 μ F is recommended. If there are multiple V_{CC} pins, 0.01 μ F or 0.022 μ F is recommended for each power pin. It is acceptable to parallel multiple bypass caps to reject different frequencies of noise. A 0.1 μ F and 1 μ F are commonly used in parallel. The bypass capacitor should be installed as close to the power pin as possible for best results.

8.3 Layout

8.3.1 Layout Guidelines

When using multiple bit logic devices inputs should not ever float.

In many cases, functions or parts of functions of digital logic devices are unused, for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used. Such input pins should not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. Specified in Figure 8-3 are the rules that must be observed under all circumstances. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that must be applied to any particular unused input depends on the function of the device. Generally they will be tied to GND or V_{CC} ; whichever makes more sense or is more convenient. It is generally acceptable to float outputs unless the part is a transceiver. If the transceiver has an output enable pin, it will disable the outputs section of the part when asserted. This will not disable the input section of the IOs, so they cannot float when disabled.

8.3.1.1 Layout Example

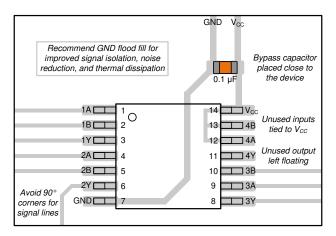


Figure 8-3. Layout Example for the SNx4AHC08



9 Device and Documentation Support

9.1 Documentation Support

9.1.1 Related Documentation

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 9-1. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY	
SN54AHC08	Click here	Click here	Click here	Click here	Click here	
SN74AHC08	Click here	Click here	Click here	Click here	Click here	

9.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

9.3 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

9.4 Trademarks

TI E2E[™] is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

9.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

9.6 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

10 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Product Folder Links: SN54AHC08 SN74AHC08



11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

www.ti.com 28-Feb-2024

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
5962-9682001Q2A	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 9682001Q2A SNJ54AHC 08FK	Samples
SN74AHC08BQAR	ACTIVE	WQFN	BQA	14	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AHC08	Samples
SN74AHC08DBR	ACTIVE	SSOP	DB	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HA08	Samples
SN74AHC08DGVR	ACTIVE	TVSOP	DGV	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HA08	Samples
SN74AHC08DR	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AHC08	Samples
SN74AHC08N	ACTIVE	PDIP	N	14	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 125	SN74AHC08N	Samples
SN74AHC08NSR	ACTIVE	SO	NS	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AHC08	Samples
SN74AHC08PWR	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU SN	Level-1-260C-UNLIM	-40 to 125	HA08	Samples
SN74AHC08PWRG4	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HA08	Samples
SN74AHC08RGYR	ACTIVE	VQFN	RGY	14	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	HA08	Samples
SNJ54AHC08FK	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 9682001Q2A SNJ54AHC 08FK	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

PACKAGE OPTION ADDENDUM

www.ti.com 28-Feb-2024

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF SN54AHC08, SN74AHC08:

Catalog: SN74AHC08

■ Enhanced Product : SN74AHC08-EP. SN74AHC08-EP

Military: SN54AHC08

NOTE: Qualified Version Definitions:

Catalog - TI's standard catalog product

• Enhanced Product - Supports Defense, Aerospace and Medical Applications

• Military - QML certified for Military and Defense Applications



www.ti.com 14-Jun-2024

TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74AHC08BQAR	WQFN	BQA	14	3000	180.0	12.4	2.8	3.3	1.1	4.0	12.0	Q1
SN74AHC08DBR	SSOP	DB	14	2000	330.0	16.4	8.35	6.6	2.4	12.0	16.0	Q1
SN74AHC08DGVR	TVSOP	DGV	14	2000	330.0	12.4	6.8	4.0	1.6	8.0	12.0	Q1
SN74AHC08DR	SOIC	D	14	2500	330.0	12.4	3.75	3.75	1.15	8.0	12.0	Q1
SN74AHC08DR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74AHC08DR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74AHC08NSR	so	NS	14	2000	330.0	16.4	8.1	10.4	2.5	12.0	16.0	Q1
SN74AHC08PWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74AHC08PWRG4	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74AHC08PWRG4	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74AHC08RGYR	VQFN	RGY	14	3000	330.0	12.4	3.75	3.75	1.15	8.0	12.0	Q1



www.ti.com 14-Jun-2024



*All dimensions are nominal

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Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74AHC08BQAR	WQFN	BQA	14	3000	210.0	185.0	35.0
SN74AHC08DBR	SSOP	DB	14	2000	356.0	356.0	35.0
SN74AHC08DGVR	TVSOP	DGV	14	2000	356.0	356.0	35.0
SN74AHC08DR	SOIC	D	14	2500	340.5	336.1	32.0
SN74AHC08DR	SOIC	D	14	2500	356.0	356.0	35.0
SN74AHC08DR	SOIC	D	14	2500	353.0	353.0	32.0
SN74AHC08NSR	so	NS	14	2000	356.0	356.0	35.0
SN74AHC08PWR	TSSOP	PW	14	2000	356.0	356.0	35.0
SN74AHC08PWRG4	TSSOP	PW	14	2000	353.0	353.0	32.0
SN74AHC08PWRG4	TSSOP	PW	14	2000	356.0	356.0	35.0
SN74AHC08RGYR	VQFN	RGY	14	3000	356.0	356.0	35.0

PACKAGE MATERIALS INFORMATION

www.ti.com 14-Jun-2024

TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
5962-9682001Q2A	FK	LCCC	20	55	506.98	12.06	2030	NA
SN74AHC08N	N	PDIP	14	25	506	13.97	11230	4.32
SN74AHC08N	N	PDIP	14	25	506	13.97	11230	4.32
SNJ54AHC08FK	FK	LCCC	20	55	506.98	12.06	2030	NA



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. QFN (Quad Flatpack No-Lead) package configuration.
- D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
- E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated. The Pin 1 identifiers are either a molded, marked, or metal feature.
- G. Package complies to JEDEC MO-241 variation BA.



RGY (S-PVQFN-N14)

PLASTIC QUAD FLATPACK NO-LEAD

THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No—Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

Exposed Thermal Pad Dimensions

4206353-2/P 03/14

NOTE: All linear dimensions are in millimeters



RGY (S-PVQFN-N14)

PLASTIC QUAD FLATPACK NO-LEAD



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat—Pack QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com http://www.ti.com.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.



2.5 x 3, 0.5 mm pitch

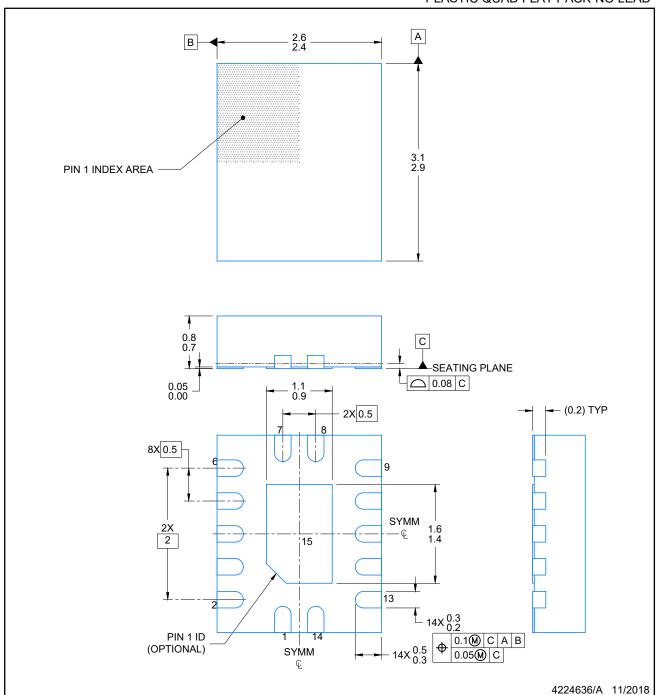
PLASTIC QUAD FLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



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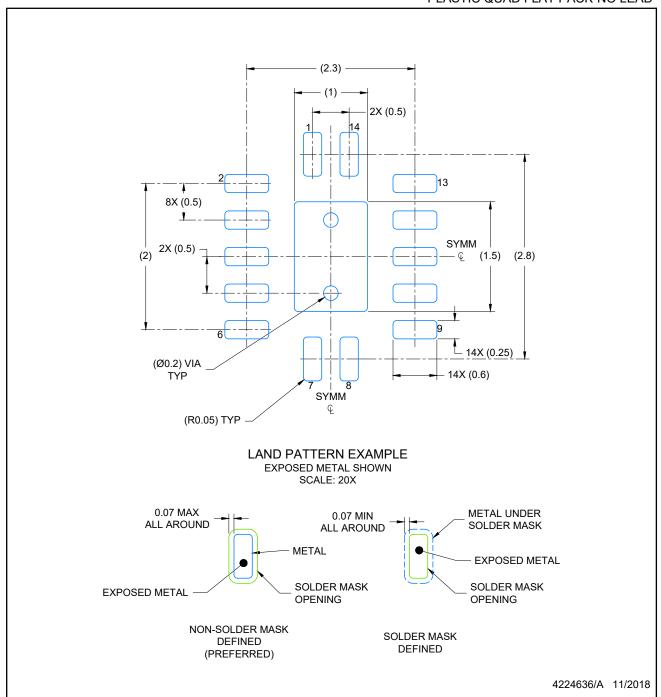
PLASTIC QUAD FLAT PACK-NO LEAD



- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for optimal thermal and mechanical performance.



PLASTIC QUAD FLAT PACK-NO LEAD

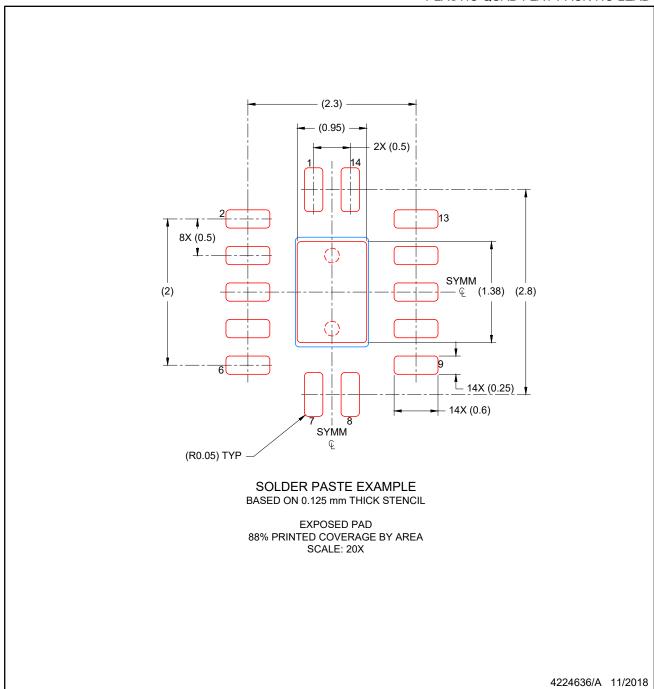


NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



PLASTIC QUAD FLAT PACK-NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



MECHANICAL DATA

NS (R-PDSO-G**)

14-PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



DGV (R-PDSO-G**)

24 PINS SHOWN

PLASTIC SMALL-OUTLINE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.

D. Falls within JEDEC: 24/48 Pins – MO-153 14/16/20/56 Pins – MO-194



SMALL OUTLINE PACKAGE



- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
 4. Reference JEDEC registration MO-150.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



8.89 x 8.89, 1.27 mm pitch

LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



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D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AB.



D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



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